

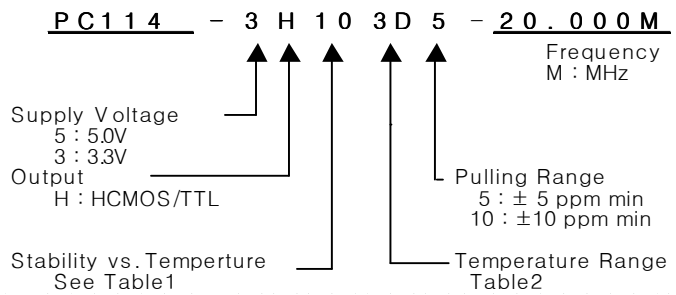
VCTCXO

PC114 Series

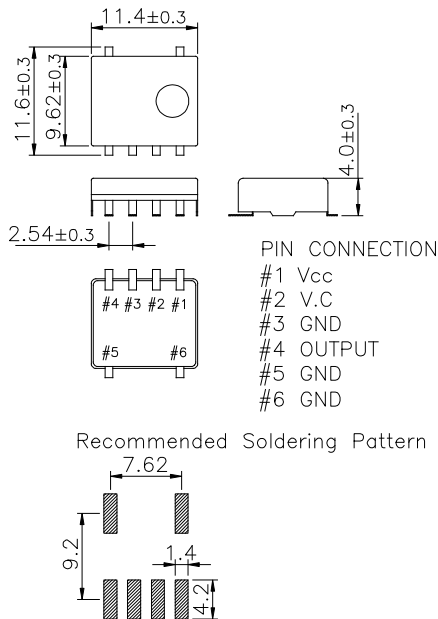
HCMOS/TTL

6PAD SMD PACKAGE

* PART NUMBERING GUIDE



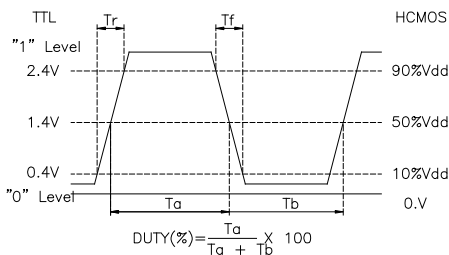
MECHANICAL DIMENSIONS



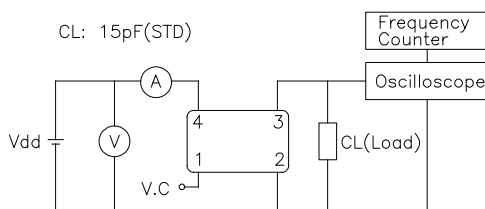
ELECTRICAL SPECIFICATION

Frequency range	1.250MHz to 50.000MHz	
Frequency Stability vs. Temperature vs. Supply Voltage vs. Load vs. Aging	±0.5 ppm to ±5.0ppm ±0.1 / ±0.3 ppm max / Vdd ± 5% ±0.2 ppm max / 15pF ±10% ±1.0 ppm max/ year	
Temperature Range Operating Storage	See Table 2 -55°C to 125°C	
Supply Voltage	3.3V ± 5% 5.0V ± 5%	
Input Current 3.3 V , 5V	1.250MHz ~ 50.000MHz 15mA max ~ 40mA max	
Output characteristics	HCMOS	TTL
Logic "1"	90% Vdd min	2.4V min
Logic "1"	10% Vdd max	0.4V min
Load	15pF	10TTL
Duty Cycle	40/60	40/60
Rise & Fall	10nS max	10nS max
Phase Noise (typical) 20MHz offset	-80 dBc / Hz @ 10Hz -120 dBc / Hz @ 100Hz -135 dBc / Hz @ 1KHz -140 dBc / Hz @ 10KHz -145 dBc / Hz @100KHz	
Frequency Adjustment	±3ppm min by internal trimmer	
Voltage Control Characteristics		
Output Pulling Range (ΔF/ΔV)	±5.0ppm or ±10ppm min (ΔF/ΔV > ±20ppm is available, please contact us)	
Control Voltage Range	1.65V ± 1.5V (Vdd : 3.3V) , 2.5V ± 2.0V (Vdd : 5.0V)	

OUTPUT WAVEFORM



TEST CIRCUIT



ENVIROMENTAL & MECHANICAL SPECIFICATION

Shock	MIL-STD-883C, Method 2002, Condition B
Vibration	MIL-STD-883C, Method 2007, Condition A
Solderability	MIL-STD-883C, Method 2003
Seal integrity	MIL-STD-883C, Method 1014, Condition C & A2
Marking	MIL-STD-202F, Method 215

TABLE1

Symbol	Stability
05	±0.5ppm
10	±1.0ppm
15	±1.5ppm
20	±2.0ppm
25	±2.5ppm
30	±3.0ppm
35	±3.5ppm
50	±5.0ppm

TABLE2

Symbol	Temp.	Symbol	Temp.
0	0°C	A	50°C
1	-10°C	B	60°C
2	-20°C	C	70°C
3	-30°C	D	75°C
4	-40°C	E	80°C
		F	85°C